

HOLY ANGEL UNIVERSITY College of Engineering and Architecture DEPARTMENT OF ELECTRONICS ENGINEERING



COURSE CODE:	4760	
COURSE:	ELECTRONIC DEVICES AND CIRCUIT THEORY LABORATORY	
SCHEDULE (Day/Time/Room):	M 1:20-4:20PM ECE LABORATORY Alcantura, John Mossile J. Sanchez, Helgena Irish D.	To, Miah Angela M.
NAME:	De Jesus, John Michael P. Tan, Ardrey Anne V.	J
GROUP No.:	6	
DATE PERFORMED: DUE DATE:	February 19, 2024 February 26, 2024	
DATE SUBMITTED:	February a6, 2024	
INSTRUCTOR:	Engr. Cherry Ann P. Navarro	

SCORE SHEET

CRITERIA						SCORE
Participation (well prepared 1-4 5-8	20%) [Ability to in class; and tim Superficial Ordinary	perform e manag 9-12 13-16	task in collabo gement skills] Satisfactory Very Good	ration wi	th teammates;	20
Data and Resu						15
Answers to Qu						W
Discussion of Fexperimental reskill; Communion 1-5 6-10	indings (25%) [A esults with respe cation skills] Unsatisfactory Deficient	ect to the	highlight the in theoretical fo Satisfactory Very Good	mplication undation 21-25	ns of the s; Analytical Excellent	25

INSTRUCTOR'S SIGNATURE:

W/



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LABORATORY MANUAL FOR ELECTRONIC DEVICES AND CIRCUIT THEORY

DATA AND RESULTS

Part 1

Table 7-1

Unit	Type Number	B neg E pos ohms	B pos E neg ohms	B pos C neg ohms	B neg C pos ohms	Is the transistor in good condition?	NPN or PNP
-	011 2000	10	00	~	0)	Good	NAN
7	2N3909	1 6	20	ص	0/	Good	NPN
2	MPSA 20	(0			10	Gova	PNP
3	2N 3906	₩ .	0	0	100	C 1	NPN
4	2222A	U	W	w/	0	Good	
5							
6		- vir		a phakaama	- 31		

Part 2

Table 7-2

7-2	Condition	Current mA		Voltage Vdc	
Step	Comunica	I _E	lc	V _{EB}	V _{CB}
3	Fig. 7-1: R2 maximum	3.8 mA	3.95mA	5.75V	0.61
4	R2 minimum	1.16mA	1.22 mA	5.94	0.563V
5,6	Fig. 7-2: R2 maximum	0.79mk	6.73 mA	5.91	1.298 4
3,0	R2 minimum	2.5mA	2.4mA	5.99 V	1.34
7	I _{cbo} = OA				

Table 7-3

Step	Condition	C	urrent mA	Voltage Vdc		
жер		IE	- I _c	V _{EB}	V _{CB}	
	Fig. 7-3: R2 maximum	3.21mA	3-42mA	0.761	0.75 V	
9 R2 minimum		2.57 mA	2-78mA	עליני. ס	0.761	
10 Fig.7- 4: R2 maximum		2.1a mA	2.65 mA	0.781	D.78	
	R2 minimum	2.02 mA	2-54 mA	Domb	0.77V	
11	I _{cbo} = OA					



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REVIEW QUESTIONS

- 1. How do you determine if a transistor is (a) shorted (b) open?
- 2. Can you check a transistor in circuit? Why or why not?
- 3. What are the effects on I_E of reversed bias on the emitter-base circuit?

Answers to Review Questions

To determine if a transistor is (a) shorted or (b) open, you can use a multimeter
1. For (a), check continuity between collector and emitter or collector and base;
for (b) measure resistance between collectur and emitter or collectur and base
2. Checking a transistor iii circuit may not provide accurate results because the other
components in the circuit can affect readings. Removing the transition from the circuit
allows for more accounte reading
3. Reversed bigs on the emitter - base growth reduces the emitter current (le)
as I inhibit the flow of majority conners leading to a decrease in
transister functionality.

DISCUSSION OF FINDINGS

examination of transister configurations reveals the cubite In conclusion an NPN &PNP configurations differences dy namice highlighting the Critical role emmitten base circuits. The collector-base circuit and eminitter-base The collector - base circutt and Ir circults. Current the vulherabity minority Carnens emphasize trougistur teriperciture changes and POSSIble handling is papamoont shorts method Immediate danger destruction the toractical 90-10-90 ohmmeter excels reliability in rodaing transistor conditions diode villes. The bias experiments highlight the direct temperature and bias control the emmitter and collector on the transistar (tand and control the dunamic N.S.P. mse PNP current through the transistor emmitten bias the inverting diodes emphasizing need to the understand ecsence. the. findings highlights the importance complex thy semmenta careful handling to transists vs deepen applications.

1) BJT organization & function three doped regions make up a BUT: t. emitter (E), base (B), and collector (c). In a BJT with NPN: the strongly electrons, which are emitter injects the mosority carriers. Base serve region, it is a little doped p-type. Masority carriers the the collector (a lightly doped collected 64 torward biasing: majority carriers (electroni) an mult biasing: because base Junction. Poperse Blas: the em itter 40 of the E-B and forms a depletion flow majorety corrier HL. Stops the reverse Bins, insected electrons of PIUW: Beconse current as aninority corriers (holes) in the and cmitter disperse into the collector, resulting in a higher collector current (IC) SHUPT than base current (IB). 2) STATIC (DC) CHaracteristics: I-V characteristics: Each P-N Junction (E-B

and (-B) follows the shockley diode equation, relating current to voltage and temperature. BJT characteristic Combining individual junction characteristics and internal current relationships yields the overall BJT to characteristics, exhibiting different regions: Active Regions: Normal operation with forward biased E-B and reverse biased C-B junctions. Saturation Region: Increased collector voltage minimally Ic due to pinch - off effect in the base. Cut-off Region: Both junctions reverse-biased, resulting in minimal leakage currents

3). Circuits for biasing: It is essential to have a steady operating point for a BJT in a circuit.

Consider methods of biasing: Fixed Bias: VBE and Ic are set using resistors

Emitter Bias: To stabilize VBE and enhance thermalstability, emitter resistors are used.

Utilizing a voltage divider to provide steady biasing voltages is known as voltage - divider bias.

signal hooded signal hybrid model to represents the AC behavior of a BJT at signal levels. this model consists of:

Resistors: represent the resistance of the base, collector and emitter regions.

Capacitars: modeling the internal capacitance between base, collector, and issuer.

Dependent current source: Relating the collector current to the base-emitter voltage.

5. Gain parameters:

Beta (B): the ratio of the change in collector current (DIC) to the change in base current (AIB) at a constant collector-emitter voltage CVCE) quantifies the current gain.

Alpha (a): The ratio of collector current to emitter current (IC/IE) indicating the collector part of the applied emitter current.

(onductance (gm): the ratio of the change in collector current to the change in base - emitter voltage (DVBE) at constant collector - emitter voltage, which represents the BJT's ability to convert changes in voltage to changes in current.

This theoretical talk provides the foundation for understanding BJTs. Engineers can utilize BJTs in a variety of electrical applications by exploring these ideas further, examining their properties, and putting them to use in real-world circuit.

BOOK .

Boylestad, R.L., & Nashelsky, L. (2014). Electronic bevices and Circuit Theory, 11th ed.

